

DECLARATION FOR PATENT APPLICATION

As a below named inventor, I hereby declare that:

My residence, post office address and citizenship are as stated below next to my name. I believe I am the original, first and sole inventor (if only one name is listed below) or an original, first and joint inventor (if plural names are listed below) of the subject matter which is claimed and for which a patent is sought on the invention entitled **Manual Control with Force-Feedback for Probe Microscopy-Based Force Spectroscopy**, which is described and claimed in

- the attached specification.
 the specification in application _____ filed on _____
 and amended on _____ (if applicable).
 international (PCT) application No. _____ filed on _____
and as amended on _____ (if applicable).

I hereby state that I have reviewed and understand the contents of the aboveidentified specification, including the claims, as amended by any amendment referred to above.

I acknowledge the duty to disclose information which is known to be material to the patentability of this application in accordance with Title 37, Code of Federal Regulations, §1.56.

I hereby claim foreign priority benefits under Title 35, United States Code, §119 of any foreign application(s) for patent or inventor's certificate listed below and have also identified below any foreign application for patent or inventor's certificate having a filing date before that of the application on which priority is claimed.

Prior Foreign Application(s)

Priority Claimed

Yes No

Yes No

Yes No

I hereby claim the benefit under Title 35, United States Code, §120 of any United States application(s) listed below and, insofar as the subject matter of each of the claims of this application is not disclosed in the prior United States application in the manner provided by the first paragraph of Title 35, United States Code, §112, I acknowledge the duty to disclose information which is known to be material to the patentability of this application as defined in Title 37, Code of Federal Regulations, §1.56 which occurred between the filing date of the prior application and the national or PCT International filing date of this application.

(Application Number)	(Filing Date)	(Status - Patented, Pending, Abandoned)
----------------------	---------------	---

(Application Number)	(Filing Date)	(Status - Patented, Pending, Abandoned)
----------------------	---------------	---

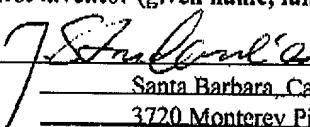
I hereby appoint the following attorney(s) and/or agent(s) to prosecute this application and to transact all business in the Patent and Trademark Office connected therewith: James F. Boyle, Reg. No. 33,653; Timothy E. Newholm, Reg. No. 34,400; David D. Stein, Reg. No. 40,828; Michael J. Gratz, Reg. No. 39,693; Mary E. Hiberle, Reg. No. 43,599; Peter C. Stomma, Reg. No. 36,020; Andrew S. McConnell, Reg. No. 32,272; Mathew E. Corr, Reg. No. 45,434; and Jay G. Durst, Reg. No. 41,723.

Address all telephone calls to Jay G. Durst at telephone number (414) 225-9755, facsimile number (414) 225-9753.

Address all correspondence to: Jay G. Durst
BOYLE, FREDRICKSON, NEWHOLM, STEIN & GRATZ, S.C.
250 Plaza, Suite 1030
250 East Wisconsin Avenue
Milwaukee, Wisconsin 53202

I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code and that such willful false statements may jeopardize the validity of the application or any patent issued thereon.

Full name of sole or first inventor (given name, family name): Jens STRUCKMEIER

Inventor's signature:  Date: 12/05/2001

Residence: Santa Barbara, California Citizenship: Germany

Post Office Address: 3720 Monterey Pine Street

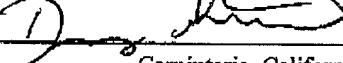
Santa Barbara, California 93105

(signatures continue – if applicable)

Title: *Manual Control with Force-Feedback for Probe Microscopy-Based Force Spectroscopy*

Inventors: Jens Struckmeier, Doug Gotthard, and Ben Ohler

Full name of second inventor (given name, family name): Doug GOTTHARD

Inventor's signature: 

Date: 12/05/2001

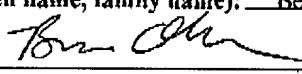
Residence: Carpinteria, California

Citizenship: USA

Post Office Address: 1015 Palmetto #E

Carpinteria, California 93013

Full name of third inventor (given name, family name): Ben OHLER

Inventor's signature: 

Date: 12/05/2001

Residence: Santa Barbara, California

Citizenship: USA

Post Office Address: 4700 Duxter Drive #15

Santa Barbara, California 93110